XPS, FTIR, EDX, and XRD Analysis of Al\(_2\)O\(_3\) Scales Grown on PM2000 Alloy

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Received 18 January 2015; Revised 20 February 2015; Accepted 25 February 2015

Academic Editor: Djordje Mandrino

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This work is an original example to compare the results obtained after calcination of Al\(_2\)O\(_3\) hydroxides and oxidation of alumino-formers alloys. FTIR and XPS signatures were obtained for various oxidation temperatures and compared with those known from the literature about calcination of Al\(_2\)O\(_3\) precursors. The aim of this work is to evaluate the use of IR spectroscopy and XPS analysis to probe the structural varieties of Al\(_2\)O\(_3\). For this objective, a study of the PM2000 oxidation at various temperatures was conducted by means of XRD, IR spectroscopy, XPS analysis, EDX analysis, and SEM observations. This allowed us to clearly differentiate the transition Al\(_2\)O\(_3\) from the \(\alpha\)-Al\(_2\)O\(_3\) and, amongst the transition Al\(_2\)O\(_3\), to differentiate the characteristic of the IR spectrum of \(\gamma\)-\(\delta\) phases from that of the \(\theta\) phase.

1. Introduction

Most of the metallic materials functioning at high temperature need to have oxidation resistance. This resistance can be achieved when the chosen materials develop through oxidation, an oxide film which acts as a diffusion barrier while keeping a good adherence. Several studies have shown that the oxide layers as SiO\(_2\), CrO\(_2\), and \(\alpha\)-Al\(_2\)O\(_3\) provide a satisfactory protective role, a protection based on the formation of a layer of \(\alpha\)-Al\(_2\)O\(_3\). Al\(_2\)O\(_3\) is the most powerful principle. In this prospect, \(\alpha\)-Al\(_2\)O\(_3\) is a very good candidate. Before reaching the most stable Al\(_2\)O\(_3\) [1], alumino-former materials developed transition Al\(_2\)O\(_3\) among which the most common are \(\gamma\), \(\delta\), and/or \(\theta\) phases. Nowadays, it is not clear whether the growth of transition Al\(_2\)O\(_3\) as a first step improves the protective properties of the further formed \(\alpha\)-Al\(_2\)O\(_3\) film. Moreover, one difficulty associated with the understanding of the influence of transition Al\(_2\)O\(_3\) on the further oxidation resistance concerns the fact that, as mentioned in [2], the techniques which allow us to detect and characterize transition Al\(_2\)O\(_3\) formed as thin layers (1 to 3 \(\mu\)m) are scarce and provide ambiguous answers. Indeed, the most common technique, the XRD, provides patterns for various Al\(_2\)O\(_3\) which are relatively close to each other. Moreover, it seems that, in many cases, several transition phases can be simultaneously present [3]. In previous studies, transmission electron microscopy (TEM) was used to probe the oxidation of either an intermetallic alloy, Fe\(_5\)Al, or an ODS (oxide dispersion strengthening) FeCrAl alloy strengthened by very small Y\(_2\)O\(_3\) particles, PM2000 [4–7]. The formation of transition Al\(_2\)O\(_3\) for various heat treatment conditions was evidenced and the transition to the \(\alpha\)-Al\(_2\)O\(_3\) was studied. The formed oxide scales were characterized using analysis techniques such as scanning electron microscope (SEM), energy-dispersive X-ray spectroscopy (EDX), X-ray diffraction (XRD), Fourier transform infrared spectroscopy (FTIR), and X-ray photoelectron spectroscopy (XPS). The present study aims at examining whether FTIR and XPS analysis may provide a simple probe to various structural varieties of Al\(_2\)O\(_3\) for applications of high temperature materials.
Schwarzkopf Plansee was used; the chemical composition in weight percent is as follows: Al-5.0, Cr-22.0, Mn-0.2, C-0.02, Si-0.3, Y-0.1, Zr-0.1, and Fe-balance. Rectangular specimens of dimensions $1 \times 1 \text{cm}^2$ and $1 \times 2 \text{cm}^2$ and thickness of $1.0 \pm 0.1 \text{mm}$ were sectioned. The oxidation of PM2000 alloy as a heat resistant material for high temperature applications was studied in air at 873, 973, 1073, 1173, 1273, 1373, and 1473 K according to the following heat treatment:

(i) heating it up to the specified temperature at 20 K/min;
(ii) maintaining it for 7 h at the oxidation temperature;
(iii) cooling it down rapidly to room temperature (air quench).

2.2. Characterization of Samples. All the samples were then characterized using XRD, SEM observations, EDX qualitative analysis, FTIR spectroscopy, and XPS spectroscopy.

(i) XRD analysis was performed with a PANalytical X’Pert ProMRD diffractometer with CuKa radiation ($\lambda = 0.15418 \text{ nm}$). Data were collected with steps of 0.02° ($2\theta$).

(ii) SEM images were taken on a field emission scanning microscope (JEOL 7500-F). The SEM used for the characterization is equipped by Genesis EDX spectroscopy system that was used to measure the composition of the elements constituting the films.

(iii) FTIR spectra were obtained using a Perkin-Elmer FTIR spectrometer at a resolution of 8 cm$^{-1}$. FTIR technique was used in the transmission mode in the 400–4000 cm$^{-1}$ range. For each sample, 120 scans were used. After oxidation, ~100 μg of the oxides was scraped. The oxide was then compressed together with 23±2 mg of KBr in a cold 150 MPa isostatic press (CIP) in order to obtain a 200–250 μm thick pellet. All IR spectra are reporting absorbance ($A = -\log(I/I_0)$) as a function of the incident wavenumbers.

(iv) An XPS spectrometer was used to qualitatively and quantitatively verify the composition of the different powder compounds. The spectra were treated using the Thermo Advantage V5.27 software. The photo-electrons are excited using a monochromatic Al-Kα radiation as the excitation source, collected at $\theta = 0°$ with respect to the surface normal and detected with a hemispherical analyzer. The spot size of the XPS source on the sample is 200 μm, and the analyzer is operated with a pass energy of 150 eV for the survey spectra and 20 eV for the accumulation spectra of the core levels. The pressure is maintained below $10^{-8}$ Torr during data collection, and the binding energies (Eb) of the obtained peaks are referenced to the C1s signal for C–H, which is set to 285.0 eV. XPS measurements are made with an uncertainty of about 0.1 eV to 0.2 eV.

2.3. SEM and EDX Analysis. For each tested temperature, oxidized specimens, contained in crucibles, were cooled to room temperature. For studies of scale morphology, composition, and crystal structure, EDX analysis was used. Figure 1 shows EDX analysis of the as-received PM2000, and the presence of the elements Fe, Cr, Al, Y, Zr, Si, Mn, and C is detected. Significant differences in the scale morphology were observed by SEM, depending on the oxidation temperature. Both materials developed Al$_2$O$_3$ scales. Figure 2(a) shows nodules form during the early stages of oxidation; they consist of oxides enriched by Al, Fe, Cr, Si, or Mg. Fe/Cr oxides were detected for temperatures between 873 and 1073 K, and cracks and porosities are observed at 1073 K, as shown in Figure 2(b). Our observations are consistent with those in the literature [8–10]. In addition to α-Al$_2$O$_3$ (detected by XRD), Figure 2(c) shows metastable Al$_2$O$_3$ which is clearly observed at 1173 K, the so-called “platelet-like” oxide, and recognized to propagate by an outward Al anion diffusion in contrary to α-Al$_2$O$_3$ scale. The presence of this type of particles was correlated with the XRD analysis and they were assumed to be β-Al$_2$O$_3$. It is well established [11, 12] that the growth rate of the metastable Al$_2$O$_3$ is of factor two to four times higher than the stable Al$_2$O$_3$, leading to faster Al consumption and as a result substantial decreasing of component’s lifetime. The external surface of metastable oxide is very different from the equiaxed dense α-Al$_2$O$_3$ grains.
Table 1: Composition and stoichiometry of the thin films obtained by statistical analysis of EDX spectrum.

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<td>0.618</td>
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Figure 2: Typical morphology of the surface scales of PM2000 after 7 h exposure at 873 K (a), 1073 K (b), 1173 K (c), and 1473 K (d).

Concerning the morphology of the oxide obtained at 1473 K, which can be seen in Figure 2(d), the formation of a bulk porous microstructure is observable, with a quite different microstructure in comparison with the a, b, c specimens. The Al₂O₃ (equiaxed grains) microstructure colonies develop into vermicular morphology containing larger scale interconnected porosity.

Data are analyzed in order to reveal the calcination effectiveness and to check the stoichiometry of the as-prepared oxide films; the results are reported in Table 1.

Figure 3(a) shows the EDX analysis samples of PM2000 (as-received and oxidized). The analyzed oxide layers are rich in Fe, Cr, and Al in the interval of temperatures between 873 K and 1073 K. For temperatures above 1173 K, Al₂O₃ becomes predominant. An example of EDX spectra of oxidized PM2000 at 1473 K is shown in Figure 3(b). As shown in Figure 3(b), the presence of Mg appears more important as the temperature increases in the α-Al₂O₃ layer. Its dissemination to the external interface is favored by higher temperatures [13].
2.4. XRD Results. PM2000 is iron-based (Fe-Cr-Al) with a ferritic matrix (α-Fe) as shown in Figure 4(a) and is mechanically alloyed with Y₂O₃ and ZrO₂ dispersion material. Before oxidation, at room temperature, native oxide, thin film exists on the alloy surface, with only several nanometers in thickness, and it consists of all the alloying elements as mentioned in literature [14]. This native oxides is Al₂O₃ and a mixture of oxides as Fe, and Cr. The oxide formation at elevated temperatures can be separated in three steps. First, at relatively low temperatures (873, 973, and 1073 K), a mixed oxide similar to the preexisting native oxide forms, the XRD does not allow the revelation of these oxides (they are revealed by SEM observations and detected by FTIR, EDX, and XPS analysis). Second, at 1173 K, the XRD pattern obtained reveals, in Figure 4(b), the presence of the α-Fe, α-Al₂O₃, transition Al₂O₃, and different phases of oxides: Fe₂O₃ or (Fe₀.₆Cr₀.₄)₂O₃ or Cr₂O₃. Third, at higher temperature greater than 1373 K, the main existing oxide is α-Al₂O₃ (Figure 4(c)).

Information on the crystallite size ($D$) for the compounds (i.e., α-Al₂O₃) was obtained from the full width at half maximum of the diffraction peaks using the Scherrer formula [15]:

$$D = \frac{0.94\lambda}{\beta(hkl) \cos \theta(hkl)},$$

where $\lambda$, $\theta(hkl)$, and $\beta(hkl)$ are the X-ray wavelength (0.15418 nm), Bragg diffraction angle, and line width at half maximum, respectively. The values of the $\beta(hkl)$ and $\theta(hkl)$ parameters from the XRD peak are estimated by Gaussian fitting. This formula is not limited by the preferential orientation and is valid for an ordinary XRD profile. To improve the statistics, the most intense peaks in the profiles were chosen to determine the crystallite size. The results are reported in Table 2.

### Table 2: Crystallite sizes versus oxidation temperature.

<table>
<thead>
<tr>
<th>Oxidation temperature</th>
<th>1273 K</th>
<th>1373 K</th>
<th>1473 K</th>
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<tr>
<td>Crystallite size ($D$) (nm)</td>
<td>36 ± 8</td>
<td>40 ± 8</td>
<td>44 ± 8</td>
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2.5. FTIR Characterizations of the Transition Al₂O₃ on Oxidized PM2000 Alloys. The FTIR spectral signatures of both α-Al₂O₃ and metastable forms have been thoroughly addressed in the literature using both experimental and theoretical simulations [16–19]. It is now possible to detect the presence of transition Al₂O₃ and perhaps their nature on oxide scales formed by oxidation of alumino-former alloys. For this purpose, PM2000 samples (PM2000, ODS alloy), oxidized at different temperatures (from 873 K to 1473 K in air for 7 hours) were studied by IR spectroscopy. FTIR spectra are reported in Figure 5. The spectrum (Figure 6(a)) at 873 K in the range 400–1000 cm⁻¹ represents a poorly crystallized structure characterized by a broadband with no apparent thin peak. This signature is that of the γ-Al₂O₃ (the broad
extending band in the range 400–700 cm$^{-1}$ indicates the existence of amorphous structure or disordered defects). The FTIR spectrum obtained after oxidation in air for 7 h of a PM2000 sample at 1073 K (Figure 6(b)) differs from the previous one. Peaks appear, indicating the presence of a better crystallized phase; the presence of $\alpha$-Al$_2$O$_3$ is also detected in this spectrum. The main peaks at 459, 595, and 656 cm$^{-1}$ can be assigned to the Al–O stretching mode in octahedral structure; bands around 715 cm$^{-1}$ and 1072 cm$^{-1}$ are related to Al–O stretching mode in tetrahedron and symmetric bending of Al–O–H, respectively. The broad absorbance bands between 900 and 1100 cm$^{-1}$ are assigned to O–H deformation vibrations. Thus, the transformation from the amorphous state to $\alpha$-Al$_2$O$_3$ can be identified from the appearance of 720
and 1072 cm$^{-1}$ bands, due to the differences in the sites of Al cations and the distribution of H in these oxides [20–22]. The presence of Fe oxides or Fe-Al oxide mixtures can make this spectrum more complex. The outer surface of the Al$_2$O$_3$ scale formed on PM2000 after 7 h oxidation at 1073 K in air was observed by SEM (Figure 2). The Al$_2$O$_3$ morphology is a characteristic of transition Al$_2$O$_3$. However, we cannot say whether it is $\delta$ or $\theta$ (or even mixtures) that are present at this temperature. The spectra (Figures 6(c) and 6(d)) of the oxidized alloys 1173, 1273, 1373, and 1473 K indicate clearly the presence of $\alpha$-Al$_2$O$_3$. Thus, the IR spectroscopy in the range 400–1000 cm$^{-1}$ can be used as a fast and easy tool to distinguish the presence of transition Al$_2$O$_3$ phases on oxidized high temperature materials and to determine whether $\gamma$, $\delta$, or $\theta$-Al$_2$O$_3$ are present. The $\alpha$-Al$_2$O$_3$ is clearly identified by its spectra shown in Figures 6(c) and 6(d). This allowed to clearly differentiate the transition Al$_2$O$_3$ from the $\alpha$-Al$_2$O$_3$ and, amongst the transition Al$_2$O$_3$, to differentiate the characteristic IR spectrum of $\gamma$- and $\delta$-phases from that of the $\theta$ phase [20, 21]. Peak observed at $\sim$ 873 cm$^{-1}$ is due to out-of-plane bending vibration ($\nu_4$–CO$_3^{2-}$) of carbonate.

2.6 XPS Results. XPS is sensitive to the chemical composition and the local environment of atoms in the crystal structure, which is reflected by the changes in the binding energy and the occurrence of multiple bands associated with different chemical environments. In the literature, the XPS analyses of Al, Fe, Cr, Mg, and Si oxides were performed and interpreted for the O1s, Al2p, Fe2p, Cr2p, Mg1s, Si1s, and C1s. XPS bands data were compared with the values reported in the literature [23–29]. XPS spectra of native oxides Fe-Cr oxides, transition Al$_2$O$_3$, and $\alpha$-Al$_2$O$_3$ have been studied by spectral characterization of each sample (the as-received PM2000, and after oxidation from 873 to 1473 K). Figure 7 shows the XPS survey spectra and the spectrum of each sample reveals the peaks for O1s, Al2p, Fe2p, Cr2p, Mg1s, Si2p, and C1s, which indicates the presence of O, Al, Fe, Cr, Mg, and Si.

The XPS Al2p spectra for treated and as-received PM2000 are shown in Figures 8(a) and 8(b) and Figures 9(a), 9(b), and 9(c). The Al2p spectra are shifted 1 eV to higher binding energy ($E_b$) in the order $\alpha$-Al$_2$O$_3$ < $\theta$-Al$_2$O$_3$ < $\gamma$-Al$_2$O$_3$. A double band is observed for the as-received PM2000; the first is located at 74.83 eV (FWHM 1.90 eV) corresponding to Al-O state and the second is located at 72.30 eV (FWHM 3.36 eV) corresponding to Al-M state. The Al2p band of oxidized alloy at 873 K (Figure 8(a)) shows a single peak located at 75.06 eV (FWHM 2.22 eV), which corresponds to the $\gamma$-Al$_2$O$_3$ form (as analyzed by FTIR spectroscopy). At 1273 K, the peak at 74.25 eV (FWHM: 1.67 eV) is affected to $\alpha$-Al$_2$O$_3$ and the peak at 74.82 eV (FWHM 2.56 eV) is affected to $\theta$-Al$_2$O$_3$ (Figure 8(b)). The results obtained for the valence Al2p for these alloys show that the variations in binding energies are within an interval of about 1 eV; these are in good agreement with previous observations [23, 26, 27]. The evolution of $\alpha$-Al$_2$O$_3$ Al2p peaks is represented in Figures 9(a) and 9(b), for temperature increasing from 873 to 1473 K. At 1373 K, the $\alpha$-Al$_2$O$_3$ peak is symmetrical and the BE position is given at 74.45 eV (FWHM 1.97 eV). The XPS decomposition peaks (Figure 9(b)) related to the energies Al2p bands are used to estimate the evolution percentage of the thermal $\alpha$-Al$_2$O$_3$ phase between 873 and 1473 K (Figure 9(c)). This trend can be divided into three parts. First, at temperatures between 873 and 1073 K, the percentage is low and does not exceed 15%; this part corresponds to the $\gamma$-Al$_2$O$_3$ and the (Fe, Cr) oxides formation. The second portion is between 1073 and 1173/1273 K; the percentage of Al is growing rapidly and has a high slope, which means a significant growth of thermal $\alpha$-Al$_2$O$_3$ and $\theta$-Al$_2$O$_3$ in this field. Finally, in a step between 1173/1273 and 1473 K, $\alpha$-Al$_2$O$_3$ takes place.
The O1s peaks are less symmetrical (relative to Al2p peaks), more complex, and more sensitive to the different states of the minerals. In fact, the O1s band is very important due to its intensity, which allows it to be more sensitive and hence more exploitable, according to the literature [23–26]. This band can be decomposed into multiple parts: the O1s band corresponding to (Fe, Cr) oxides is located at ∼529 eV, the O1s band corresponding to Al2O3 oxides is located at ∼531 eV, the O1s band corresponding to the OH groups is located at ∼532 eV, and the O1s band indicating the presence of amorphous mixtures containing H2O is located at ∼533.5 eV.

Figure 10(a) represents O1s peaks of as-received and treated PM2000. We note that these peaks exhibit significant differences depending on the compound state. In the as-received PM2000, the energy of O1s is shifted to 531.84 eV.
**Figure 7:** XPS survey spectra of as-received and oxidized PM2000.

**Figure 8:** Single Al2p peak of oxidized PM2000 at 873 K (a) and decomposed Al2p peak of oxidized PM2000 at 1273 K (b).
(FWHM 2.54 eV), the surface of the material contains a few thin native oxide. These native oxides are mainly composed of Al, Fe, and Cr. The O1s core level photoemission spectra for PM2000 (873) and PM2000 (973) confirm the presence of, at least, two oxides and eventually hydroxides. At 873 K (Figure 10(b)), when decomposed, the peak at 529.69 eV (FWHM 1.28 eV) indicates the presence of the Fe, Cr oxides [28, 29], the peak at 531.67 eV (FWHM 2.11 eV) indicates the presence of the transition Al₂O₃ oxides (the γ-Al₂O₃ form), and the O1s band indicating the presence hydroxyls is located at 532.80 eV (FWHM 1.50 eV). The peak at 1073 K (Figure 10(c)), when decomposed, indicates the presence of the transition Al₂O₃ located at 531.43 eV (FWHM 2.83 eV) with the percentage of ∼94.3%, and the peak at 529 eV (FWHM 1.91 eV) indicates the presence of (Fe, Cr) oxide with the percentage of ∼5.7%. For PM2000 (1373) shown...
Figure 10: XPS spectra in the O1s region for as-received and treated PM2000 at various temperatures (a), decomposed O1s peaks of oxidized PM2000 at 873 K (b), decomposed O1s peaks of oxidized PM2000 at 1073 K (c), and decomposed O1s peaks of oxidized PM2000 at 1373 K (d).
in Figure 10(d), the wide peak at 531.14 (FWHM 2.12 eV) indicates the presence of the $\alpha$-Al$_2$O$_3$ with the percentage of $\sim$96%, and a small peak at 532.11 eV (1.45 eV) due to the presence of the OH groups.

The Fe oxidation state of the oxides formed at various temperatures oxidations can be derived from the Fe2p spectra in Figure 11. Fe2p$_{3/2}$ and Fe2p$_{1/2}$ main line peak positions are 710.5 and 724.0 eV, respectively, which is in excellent agreement with the literature values for the mixed Fe$_2$O$_3$-(maghemite-) Fe$_3$O$_4$ (magnetite) surface [30–32]. In addition, the occurrence and intensity of the so-called Fe2p$_{3/2}$ charge-transfer satellites, which appear additionally to the Fe2p$_{3/2}$ main line, indicate the oxidation state of different Fe oxides. In the case of Fe$_3$O$_4$, the Fe$^{3+}$ charge-transfer satellite should occur at 719 eV, while for divalent FeO, the Fe$^{2+}$ satellite appears at 715.5 eV. For the mixed valence state of Fe$_2$O$_3$ (Fe$^{3+}$:Fe$^{2+} = 2:1$), both satellites add up in such a way that the spectral region between the 2p$_{3/2}$ and 2p$_{1/2}$ main lines becomes smooth and less structured [28–33]. In all samples, Fe2p peaks have asymmetric shape. In the spectrum of the as-received PM2000, the peaks corresponding to metallic Fe are specified at 706.93 eV and 707.89 eV, satellite main lines become smooth and less structured [30–33]. In all samples, Fe2p peaks have asymmetric shape. In the spectrum of the as-received PM2000, the peaks corresponding to metallic Fe are specified at 706.93 eV and 707.89 eV, satellite main lines become smooth and less structured [28–33]. In all samples, Fe2p peaks have asymmetric shape. In the spectrum of the as-received PM2000, the peaks corresponding to metallic Fe are specified at 706.93 eV and 707.89 eV, satellite main lines become smooth and less structured [28–33]. In all samples, Fe2p peaks have asymmetric shape.

The Cr oxidation state of the oxides formed at various temperatures oxidations can be derived from the Cr2p spectra in Figure 12, and the peaks observed at 577 eV and 586.5 eV indicate Cr2p$_{3/2}$ electrons and Cr$_2$O$_3$ presence in the formed oxide. A satellite of the Cr2p$_{3/2}$ peak overlaps the Cr2p$_{1/2}$ component in Cr$_2$O$_3$. The peaks at 577.6 eV and 586.38 suggest Cr2p$_{3/2}$ and Cr2p$_{1/2}$ core electrons, respectively. The Cr2p$_{3/2}$ and 2p$_{1/2}$ main line peak positions are in the range 775–582 eV and 582–590 eV, respectively, being in excellent agreement with literature values [34,35]. In all samples, Cr2p peaks have asymmetric shape. In the spectrum of the as-received PM2000, the peaks corresponding to metallic Cr at 574.39 eV and 575.02 eV are identified. A Cr2p$_{3/2}$ peak of native oxides is located in the range 576–579 eV. When oxidizing at 873 K and 973 K, the spectra corresponding to the Cr2p$_{3/2}$ and Cr2p$_{1/2}$ bands are significant and located in the range 576–589 eV and 584–590 eV, respectively (Figures 12(a) and 12(b)). The existence of Cr$_2$O$_3$ was IR from a peak at 579.60 eV. For the oxidations at temperatures above 1073 K, these bands become negligible.

The SiO$_2$ and SiC are found by XPS peak (Si2p bands) positions 99.4 eV, 103.5 eV, and 100.3 eV, respectively. Peaks obtained are 100.87 eV and 97.75 eV (Figure 13), which reveals the presence of SiC and eventually Si. This compound is quite stable, since the alloy receiver (native oxide) and the amount do not change during oxidation. The addition of small quantities of colloidal SiO$_2$ to a commercial Al$_2$O$_3$ powder has a significant effect on its densification and microstructure evolution [36,37]. SiO$_2$ has a detrimental effect on the Al$_2$O$_3$ densification behavior particularly during the intermediate stage of sintering (from 1473 to 1673 K).

As mentioned above, the presence of Mg appears more important as the temperature increases. Its dissemination to the external interface is favored by higher temperatures as shown in Figure 14. Mg doping $\alpha$-Al$_2$O$_3$ improved densification and elimination of residual porosity [38]. Works demonstrate that Mg additions uniformly distributed over a nanometer-sized Al$_2$O$_3$ powder have no effect on the $\gamma$ to $\delta$ phase transition, raise the densification rate in the rapid-sintering stage, and increase the net shrinkage [39].

2.7. Adventitious C (Carbon). The decomposition of the C1s signal in the domain (oxidation PM2000 at 873–1473 K) results in too bands (Figures 15(a) and 15(b)). The peak at $\sim$285.0 eV is associated with the binding energy of the C atoms in aromatic C–C/C–H [40], and the peak at 288.55 eV can be attributed to the binding energy of the carboxylic group (O–C=O), which is in agreement with the literature results [41].

3. Conclusion

The aim of this work was to determine whether IR spectroscopy and XPS could allow us to easily distinguish the different structural varieties of Al$_2$O$_3$ and therefore be used as a rapid diagnostics to evidence the phases present in the protective layers of high temperature materials. It was thus possible to determine the FTIR spectra of Al$_2$O$_3$ phases and the XPS analysis at different temperatures of oxidation and to evidence a continuous evolution leading to the simultaneous presence of several Al$_2$O$_3$ phases. These results have allowed us to determine some characteristic IR and XPS peaks, that is, signatures, for the various transition Al$_2$O$_3$ phases and $\alpha$-Al$_2$O$_3$. Using these IR and XPS signatures, it is possible to detect the presence of transition Al$_2$O$_3$ naturally grown on Al$_2$O$_3$-former alloys. A detailed example is presented for the oxidation of PM2000 ODS alloy. Indeed, many high temperature metallic materials develop Al$_2$O$_3$ scales that can act as protective layer against an aggressive environment. In the first stage, mixed Fe, Cr oxides, and transition Al$_2$O$_3$ appear; afterwards Al$_2$O$_3$ oxides become gradually the major as the oxidation temperature increases before transformation into the most stable $\alpha$-Al$_2$O$_3$ structure. Although the physical properties of the transition Al$_2$O$_3$ differ, their identification is not straightforward.

**Highlights**

(i) FTIR and XPS techniques were used to clarify the evolution of oxides formed on the alloy PM2000.

(ii) The percentage of the thermal $\alpha$-Al$_2$O$_3$ formation was estimated by XPS analysis as a function of temperature.
Figure 11: XPS spectra in the Fe2p region for as-received and treated PM2000 at various temperatures (a), decomposed O1s peaks of as-received PM2000 (b), decomposed O1s peaks of oxidized PM2000 at 873 K (c), and decomposed O1s peaks of oxidized PM2000 at 1473 K (d).
Figure 12: XPS spectra in the Cr2p region for as-received and treated PM2000 at various temperatures (a) and decomposed Cr2p peaks of oxidized PM2000 at 973 K (b).

Figure 13: Decomposed Si2p peaks of oxidized PM2000 at 1073 K.
Figure 14: XPS spectra in the Mg2p region for treated PM2000 from 1073 K to 1473 K.

Figure 15: XPS spectra in the C1s region for treated and as-received PM2000 at various temperatures (a) and decomposed C1s peak of oxidized PM2000 at 1073 K (b).
Conflict of Interests

The authors declare that there is no conflict of interests regarding the publication of this paper.

Acknowledgments

This work was partly supported by the National Project Research (PNR) and LASPI² A laboratory of Khenchela University, Algeria.

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